

Octal transceiver with direction pin (3-State)

54ABT245

FEATURES

- Octal bidirectional bus interface
- 3-State buffers
- Output capability: +48mA/-24mA
- Latch-up protection exceeds 500mA per Jedec JC40.2 Std 17

- ESD protection exceeds 2000V per MIL STD 883C Method 3015.6

DESCRIPTION

The 54ABT245 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 54ABT245 device is an octal transceiver featuring noninverting 3-State bus compatible outputs in both send and receive directions. The control function implementation minimizes external timing requirements. The device features an Output Enable (OE) input for easy cascading and a Direction (DIR) input for direction control.

ORDERING INFORMATION

DESCRIPTION	ORDER CODE	PACKAGE DESIGNATOR*
20-Pin Ceramic DIP	54ABT245/BRA	GDIP1-T20
20-Pin Ceramic LLCC	54ABT245/B2A	CQCC2-N20

* MIL-STD 1835 or Appendix A of 1995 Military Data Handbook

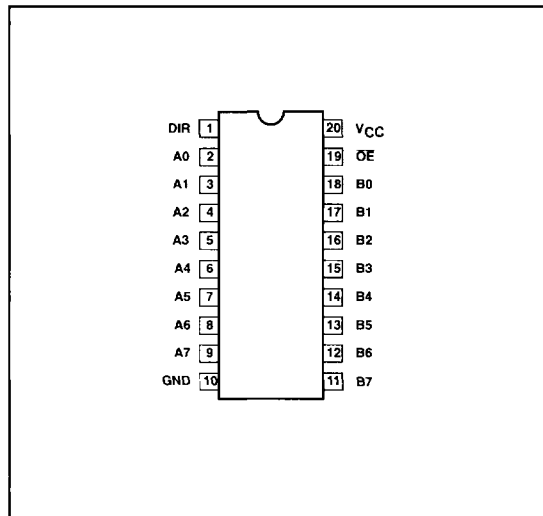
FUNCTION TABLE

INPUTS		INPUTS/OUTPUTS	
OE	DIR	A _n	B _n
L	L	A=B	Inputs
L	H	Inputs	B=A
H	X	Z	Z

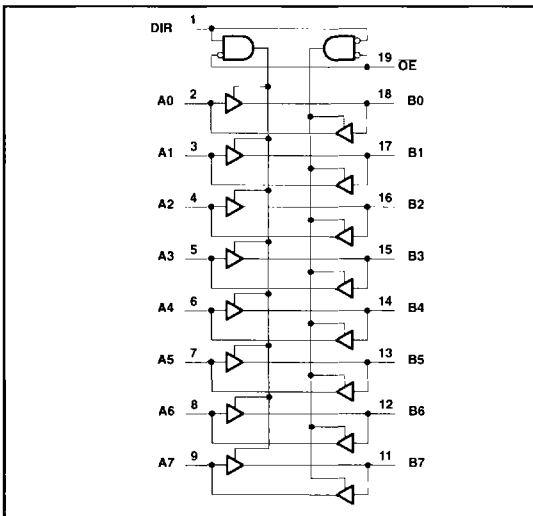
PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
1	DIR	Direction control input
2, 3, 4, 5, 6, 7, 8, 9	A0 - A7	Data inputs/outputs (A side)
18, 17, 16, 15, 14, 13, 12, 11	B0 - B7	Data inputs/outputs (B side)
19	OE	Output enable
10	GND	Ground (0V)
20	V _{CC}	Positive supply voltage

PIN CONFIGURATION



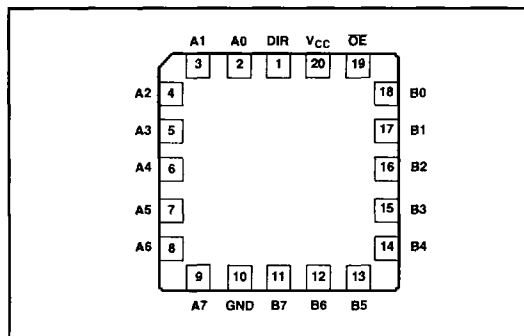
LOGIC SYMBOL



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LLCC LEAD CONFIGURATION

ABSOLUTE MAXIMUM RATINGS¹

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V_{CC}	DC supply voltage		-0.5 to +7.0	V
V_I	DC input voltage ³	DIR, OE	-1.2 to +7.0	V
		A _n , B _n	-1.2 to +5.5	V
I_{OK}	DC output diode current	$V_O < 0$	-50	mA
V_O	DC output voltage ²	Output in Off or High state	-0.5 to +5.5	V
I_O	DC output current	Output in Low state	96	mA
T_{stg}	Storage temperature range		-65 to 150	°C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS		UNIT
		MIN	MAX	
V_{CC}	DC supply voltage	4.5	5.5	V
I_{IK}	Input clamp current		-18	mA
I_{OH1}	High level output current		-3	mA
I_{OH2}	High level output current		-24	mA
I_{OL}	Low level output current		48	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0	5	ns/V
T_{amb}	Operating free-air temperature range	-55	+125	°C
V_{IL}	Input Low level voltage		0.8	V
V_{IH}	Input High level voltage	2.0		V

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DC ELECTRICAL CHARACTERISTICS

(Unless otherwise noted: $V_{CC} = \text{MAX}$, $V_I = V_{IL}$ or V_{IH} , $T_{amb} = -55$ to $+125^\circ\text{C}$.)

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
V_{IK}	Input clamp voltage	$V_{CC} = \text{MIN}$, $I_I = I_{IK}$			-1.2	V
V_{OH}	High-level output voltage	$V_{CC} = \text{MIN}$				V
		$I_{OH1} = -3\text{mA}$	2.5			V
		$I_{OH2} = -24\text{mA}$	2.0			V
		$V_{CC} = 5.0\text{V}$				V
		$I_{OH} = -3\text{mA}$	3.0			V
V_{OL}	Low-level output voltage	$V_{CC} = \text{MIN}$, $V_I = V_{IL}$ or V_{IH} , $I_{OL} = \text{MAX}$		0.42	0.55	V
I_I	Input leakage current	Control Pins	$V_I = \text{GND}$ or 5.5V	± 0.01	± 1.0	μA
		Data Pins ⁶	$V_I = \text{GND}$ or 5.5V	± 5	± 100	μA
$I_{IH} + I_{OZH}$	3-State output High current	$V_{CC} = \text{MAX}$, $V_O = 2.7\text{V}$, $V_I = V_{IL}$ or 3.0V		5.0	10	μA
$I_{IL} + I_{OZL}$	3-State output Low current	$V_{CC} = \text{MAX}$, $V_O = 0.5\text{V}$, $V_I = V_{IL}$ or 3.0V		-5.0	-10	μA
I_{OFF}	Power off leakage current	$V_{CC} = 0\text{V}$, V_I or $V_O \leq 4.5\text{V}$	-100	1.0	100	μA
I_{CEX}	Output high leakage current	$V_{CC} = 5.5\text{V}$, $V_O = 5.5\text{V}$			50	μA
I_O	Output current ⁹	$V_{CC} = \text{MAX}$, $V_O = 2.5\text{V}$	-50	-100	-180	mA
I_{CCH}	Quiescent supply current	$V_{CC} = \text{MAX}$, Outputs High, $V_I = \text{GND}$ or V_{CC}		50	250	μA
I_{CCL}		$V_{CC} = \text{MAX}$, Outputs Low, $V_I = \text{GND}$ or V_{CC}		24	30	mA
I_{CCZ}		$V_{CC} = \text{MAX}$, Outputs 3-State, $V_I = \text{GND}$ or V_{CC}		50	250	μA
ΔI_{CC}	Additional supply current per input pin ⁴	Outputs enabled, one input at 3.4V , other inputs at V_{CC} or GND , $V_{CC} = \text{MAX}$		0.5	1.5	mA
		Outputs 3-State, one data input at 3.4V , other inputs at V_{CC} or GND , $V_{CC} = \text{MAX}$ ⁵		0.5	50	μA
		Outputs 3-State, one enable input at 3.4V , other inputs at V_{CC} or GND , $V_{CC} = \text{MAX}$		0.5	1.5	mA

AC CHARACTERISTICS

SYMBOL	PARAMETER	WAVEFORM	LIMITS						UNIT
			T _{amb} = +25°C V _{CC} = +5.0V C _L = 50pF, R _L = 500Ω			T _{amb} = -55°C to +125°C V _{CC} = +5.0V ±0.5V C _L = 50pF, R _L = 500Ω			
			Min	Typ	Max	Min	Max		
t _{PLH} t _{PHL}	Propagation delay An to Bn or Bn to An	1	1.0 1.0	2.2 2.9	4.1 4.2	1.0 1.0	4.8 4.8	ns	
t _{pZH} t _{pZL}	Output enable time to High and Low level	2	1.3 2.3	2.9 4.0	4.8 5.8	1.0 2.0	5.9 7.5	ns	
t _{pHZ} t _{pLZ}	Output disable time from High and Low level	2	2.7 2.3	4.7 4.0	6.2 5.8	2.2 2.0	7.4 6.5	ns	

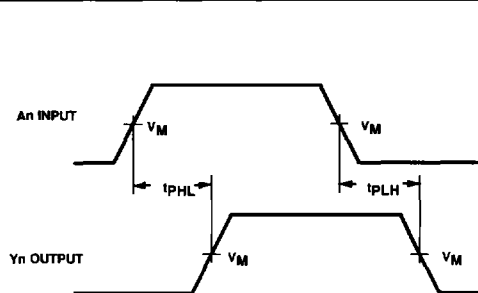
NOTES:

- Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
- Not more than one output should be tested at a time, and the duration of the test should not exceed one second.
- This is the increase in supply current for each input at 3.4V .
- Typical value does not include leakage due to external capacitance or fixturing.
- Input leakage on transceiver data pins also includes I_{OZH} or I_{OZL} current from the output circuitry.

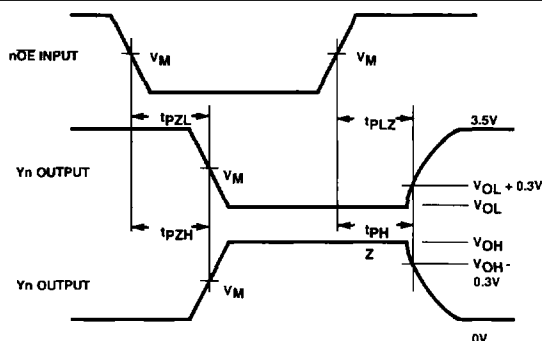
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AC WAVEFORMS

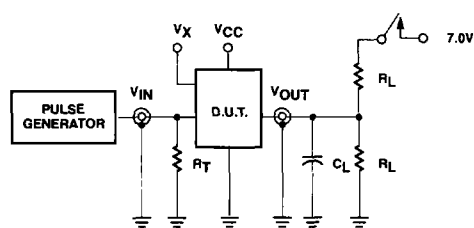
 $V_M = 1.5V$, $V_{IN} = GND$ to $3.0V$ 

Waveform 1. Waveforms Showing the Input to Output Propagation Delays



Waveform 2. Waveforms Showing the 3-State Output Enable and Disable Times

TEST CIRCUIT AND WAVEFORMS

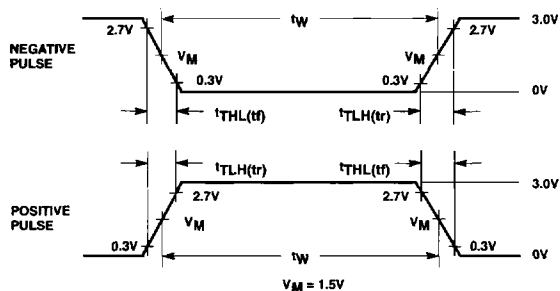


Test Circuit for 3-State Outputs

SWITCH POSITION

TEST	SWITCH
t_{PLZ} , t_{PZL}	closed
All other	open

DEFINITIONS:

 R_L = Load Resistor; see AC Characteristics for value. C_L = Load capacitance includes jig and probe capacitance; see AC Characteristics for value. R_T = Termination resistance should be equal to Z_{OUT} of pulse generators. V_X = Unlocked pins must be held at: $\leq 0.8V$; $\geq 2.7V$ or open per Function Table.

Input Pulse Definitions

INPUT PULSE CHARACTERISTICS

Family	Rep. Rate	Pulse Width	t_{TLH}	t_{THL}
54ABT	1MHz	500ns	$\leq 2.5ns$	$\leq 2.5ns$